

STB5N80K5

N-channel 800 V, 1.50 Ω typ., 4 A MDmesh[™] K5 Power MOSFET in a D²PAK package

Datasheet - production data

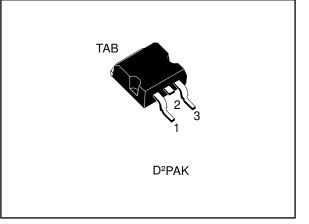
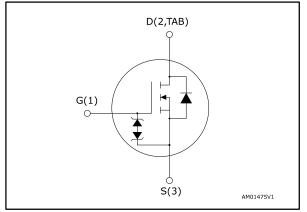


Figure 1: Internal schematic diagram



Features

Order code	VDS	RDS(on) max.	ID
STB5N80K5	800 V	1.75 Ω	4 A

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh[™] K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

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Order code	Marking	Package	Packing				
STB5N80K5	5N80K5	D ² PAK	Tape and reel				

This is information on a product in full production.

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
Vgs	Gate-source voltage	± 30	V
ID	Drain current (continuous) at $T_C = 25 \ ^\circ C$	4	А
ID	Drain current (continuous) at Tc = 100 °C	2.3	А
ld ⁽¹⁾	Drain current (pulsed)	16	А
Ртот	Total dissipation at $T_C = 25 \text{ °C}$	60 V	
dv/dt ⁽²⁾	Peak diode recovery voltage slope	4.5	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50 V	
Tj	Operating junction temperature range	EE to 150 %	
T _{stg}	Storage temperature range	- 55 to 150	°C

Notes:

 ${\ensuremath{^{(1)}}}\xspace{\mathsf{Pulse}}$ width limited by safe operating area

 $^{(2)}I_{SD} \leq 4$ A, di/dt =100 A/µs; V_Ds peak < V_(BR)DSS, V_DD=640 V $^{(3)}V_{DS} \leq 640$ V

Table 3: Thermal data

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case	2.08	°C/W
Rthj-pcb ⁽¹⁾	Thermal resistance junction-pcb	35	°C/W

Notes:

 $^{(1)}\!When$ mounted on FR-4 board of 1 inch², 2 oz Cu

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
lar	Avalanche current, repetitive or not repetitive (pulse width limited by Tjmax)	1.2	A
Eas	Single pulse avalanche energy (starting Tj = 25 °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	165	mJ



2 Electrical characteristics

 $T_C = 25 \ ^{\circ}C$ unless otherwise specified

Table 5: On/off-state							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 V$, $I_D = 1 mA$	800			V	
		$V_{GS} = 0 V, V_{DS} = 800 V$			1	μA	
IDSS	Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 800 V$ T _c = 125 °C ⁽¹⁾			50	μA	
I _{GSS}	Gate body leakage current	$V_{\text{DS}} = 0 \text{ V}, V_{\text{GS}} = \pm 20 \text{ V}$			±10	μA	
$V_{GS(th)}$	Gate threshold voltage	$V_{\text{DD}} = V_{\text{GS}}, I_{\text{D}} = 100 \ \mu\text{A}$	3	4	5	V	
R _{DS(on)}	Static drain-source on-resistance	$V_{GS}=10~V,~I_{D}=2~A$		1.50	1.75	Ω	

Table 5: On/off-state

Notes:

⁽¹⁾Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	177	-	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0 V	-	15	-	pF
Crss	Reverse transfer capacitance		-	0.3	-	pF
Co(tr) ⁽¹⁾	Equivalent capacitance time related		-	33	-	рF
$C_{o(er)}^{(2)}$	Equivalent capacitance energy related	$V_{GS} = 0, V_{DS} = 0$ to 640 V		12		pF
Rg	Intrinsic gate resistance	$f = 1 \text{ MHz}$, $I_D = 0 \text{ A}$	-	16	-	Ω
Qg	Total gate charge	$V_{DD} = 640 \text{ V}, \text{ I}_{D} = 4 \text{ A}$	-	5	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	1.7	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15: "Test circuit for gate charge behavior")	-	2.9	-	nC

Table 6: Dynamic

Notes:

 $^{(1)}C_{0(tr)}$ is a constant capacitance value that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

 $^{(2)}C_{0(er)}$ is a constant capacitance value that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .



Electrical characteristics

	Table 7: Switching times							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
td(on)	Turn-on delay time	$V_{\text{DD}}\text{=}$ 400 V, I_{D} = 2 A, R_{G} = 4.7 Ω	-	12.7	-	ns		
tr	Rise time	V _{GS} = 10 V	-	11.7	-	ns		
td(off)	Turn-off delay time	(see Figure 14: "Test circuit for resistive load switching times"	-	23	-	ns		
tr	Fall time	resistive load switching times" and Figure 19: "Switching time waveform")	-	14.8	-	ns		

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isd	Source-drain current		-		4	А
Isdm ⁽¹⁾	Source-drain current (pulsed)		-		16	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 4 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	-		1.5	V
trr	Reverse recovery time	$I_{SD} = 4 \text{ A}, \text{ di/dt} = 100$	-	265		ns
Qrr	Reverse recovery charge	A/μs,V _{DD} = 60 V (see <i>Figure 16: "Test circuit</i>	-	1.59		μC
I _{RRM}	Reverse recovery current	for inductive load switching and diode recovery times")	-	12		А
trr	Reverse recovery time	$I_{SD} = 4 \text{ A}, \text{di/dt} = 100 \text{ A/}\mu\text{s}$	-	386		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V, T _j = 150 °C (see <i>Figure 16: "Test circuit</i>	-	2.18		μC
IRRM	Reverse recovery current	for inductive load switching and diode recovery times")	-	11.3		A

Notes:

 ${\ensuremath{^{(1)}}}\xspace \mathsf{Pulse}$ width limited by safe operating area

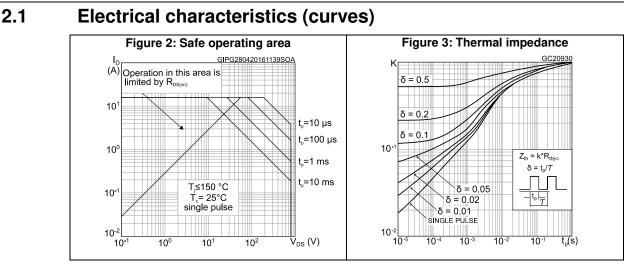
 $^{(2)}$ Pulsed: pulse duration = 300 µs, duty cycle 1.5%

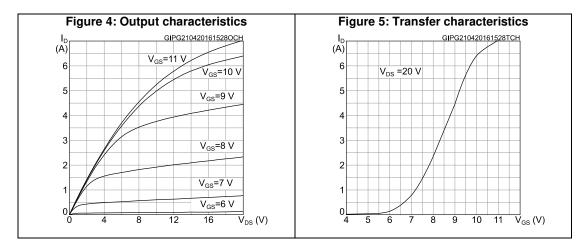
Table 9: Gate-source Zener diode

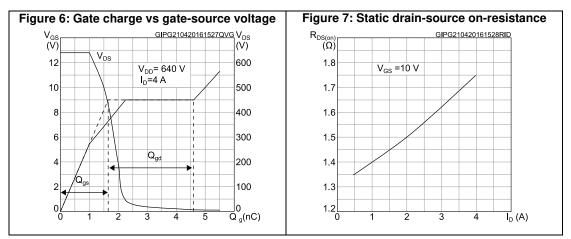
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _(BR) GSO	Gate-source breakdown voltage	$I_{GS}=\pm 1mA$, $I_{D}=0A$	30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

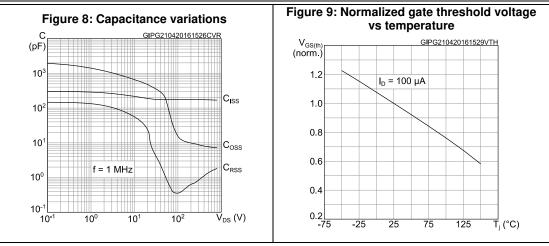


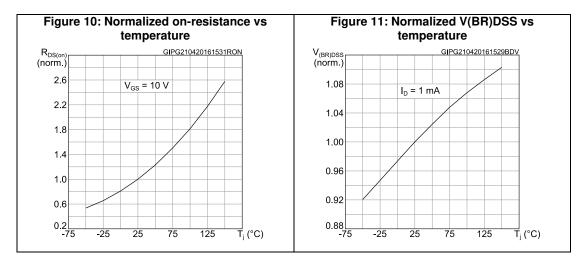


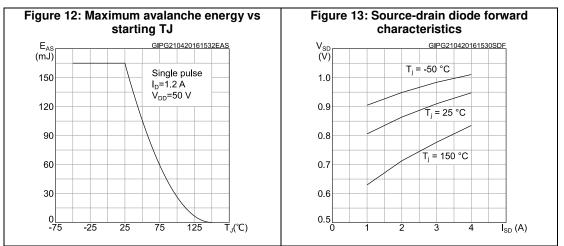






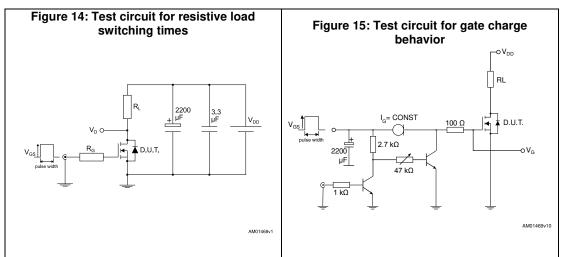


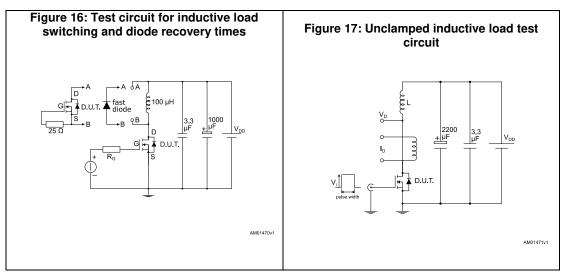


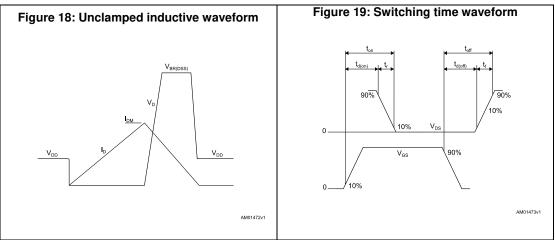


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3 Test circuits







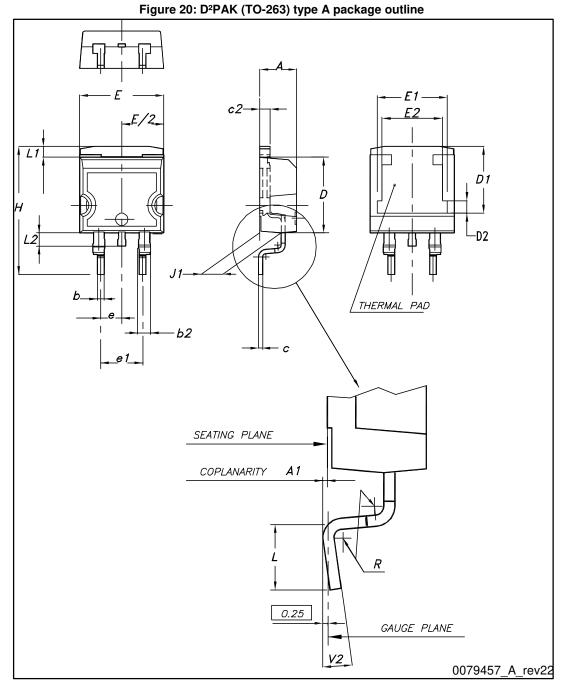


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4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

4.1 D²PAK (TO-263) type A package information



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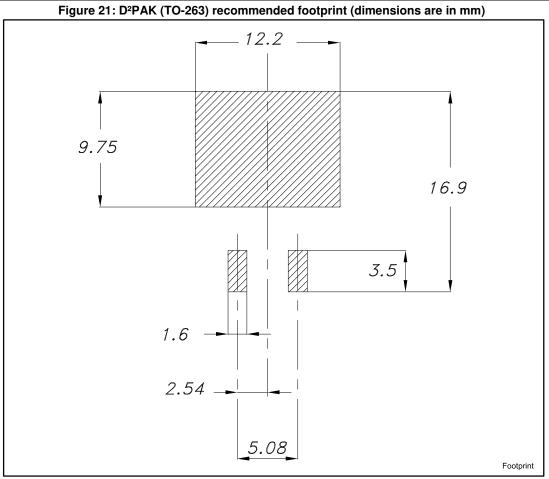
Package information

STB5N80K5

nformation							
Tabl	e 10: D²PAK (TO-263) ty		al data				
Dim.	mm						
	Min.	Тур.	Max.				
А	4.40		4.60				
A1	0.03		0.23				
b	0.70		0.93				
b2	1.14		1.70				
С	0.45		0.60				
c2	1.23		1.36				
D	8.95		9.35				
D1	7.50	7.75	8.00				
D2	1.10	1.30	1.50				
E	10		10.40				
E1	8.50	8.70	8.90				
E2	6.85	7.05	7.25				
е		2.54					
e1	4.88		5.28				
Н	15		15.85				
J1	2.49		2.69				
L	2.29		2.79				
L1	1.27		1.40				
L2	1.30		1.75				
R		0.4					
V2	0°		8°				

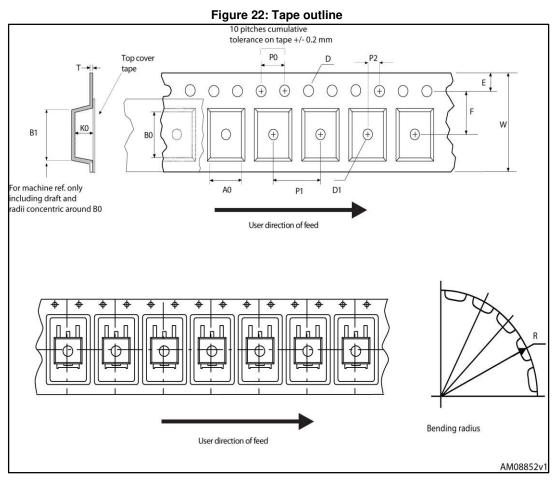
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4.2 Packing information





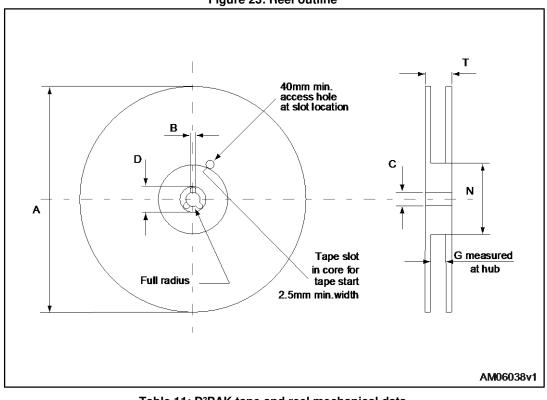


Table 11: D ² PAK tape	and reel	mechar	nical da	ata
-				

Таре			Reel		
Dim.	n	ım	Dim	m	m
Dim.	Min.	Max.	Dim.	Min.	Max.
A0	10.5	10.7	A		330
B0	15.7	15.9	В	1.5	
D	1.5	1.6	С	12.8	13.2
D1	1.59	1.61	D	20.2	
E	1.65	1.85	G	24.4	26.4
F	11.4	11.6	N	100	
К0	4.8	5.0	Т		30.4
P0	3.9	4.1			
P1	11.9	12.1	Base quantity 10		1000
P2	1.9	2.1	Bulk quantity		1000
R	50				
Т	0.25	0.35			
W	23.7	24.3			



Revision history 5

Table 12: Document	revision histor	у
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Date	Revision	Changes
19-Nov-2015	1	First release.
09-May-2016	2	Modified: Table 2: "Absolute maximum ratings", Table 3: "Thermal data", Table 5: "On/off-state", Table 6: "Dynamic", Table 7: "Switching times" and Table 8: "Source-drain diode" Updated: Section 4: "Test circuits" Added: Section 3.1: "Electrical characteristics (curves)" Minor text changes.



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